

# P-Channel Enhancement Mode Power MOSFET

### Description

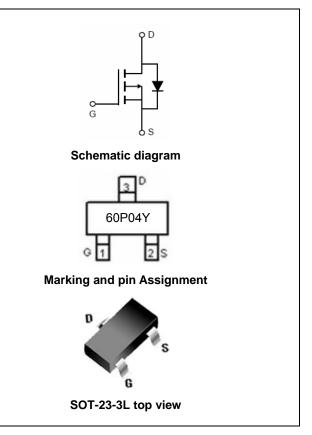
The HM2309A uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge .This device is well suited for use as a load switch or in PWM applications.

### **General Features**

- $V_{DS} = -60V, I_D = -4A$   $R_{DS(ON)} < 120m\Omega @ V_{GS} = -10V$  $R_{DS(ON)} < 170m\Omega @ V_{GS} = -4.5V$
- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Excellent package for good heat dissipation

#### Application

- Load switch
- PWM application



### Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
60P04Y	HM2309A	SOT-23-3L	Ø180mm	8 mm	3000 units

### Absolute Maximum Ratings (T<sub>c</sub>=25℃unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	Vds	-60	V
Gate-Source Voltage	Vgs	±20	V
Drain Current-Continuous	Ι <sub>D</sub>	-4	А
Pulsed Drain Current	I <sub>DM</sub>	-12	А
Maximum Power Dissipation	PD	1.5	W
Operating Junction and Storage Temperature Range	T <sub>J</sub> ,T <sub>STG</sub>	-55 To 150	°C

## **Thermal Characteristic**

Thermal Resistance, Junction-to-Ambient <sup>(Note 2)</sup>	R <sub>θJA</sub>	83.3	°C <b>/W</b>	
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## Electrical Characteristics (T<sub>C</sub>=25°C unless otherwise noted)

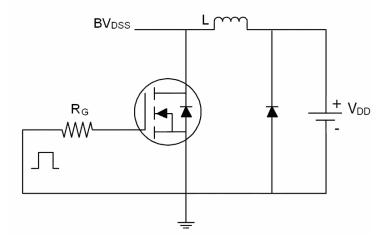
Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics	· · ·		•	•		
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =-250µA -6		-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =-60V,V <sub>GS</sub> =0V	-	-	-1	μΑ
Gate-Body Leakage Current	I <sub>GSS</sub>	$V_{GS}$ =±20V, $V_{DS}$ =0V	-	-	±100	nA
On Characteristics (Note 3)	· · ·		•	•		
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS}=V_{GS}$ , $I_{D}=-250\mu A$	-1.5	-2.2	-3.0	V
Drain-Source On-State Resistance	_	$V_{GS}$ =-10V, I <sub>D</sub> =-4A	-	106	120	mΩ
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	$V_{GS}$ =-4.5V, I <sub>D</sub> =-3A	-	135	170	mΩ
Forward Transconductance	<b>g</b> fs	V <sub>DS</sub> =-5V,I <sub>D</sub> =-4A		10	-	S
Dynamic Characteristics (Note4)	· · · · ·					
Input Capacitance	C <sub>lss</sub>	)/ - 20)/// -0)/	-	930	-	PF
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> =-30V,V <sub>GS</sub> =0V, F=1.0MHz	-	85	-	PF
Reverse Transfer Capacitance	C <sub>rss</sub>		-	35	-	PF
Switching Characteristics (Note 4)	· · ·		•	•		
Turn-on Delay Time	t <sub>d(on)</sub>		-	8	-	nS
Turn-on Rise Time	tr	$V_{DD}$ =-30V, R <sub>L</sub> =7.5 $\Omega$ ,	-	4	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS}$ =-10V,R <sub>G</sub> =3Ω	-	32	-	nS
Turn-Off Fall Time	t <sub>f</sub>		-	7	-	nS
Total Gate Charge	Qg	$V_{-201} = 40$	-	25	-	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> =-30,I <sub>D</sub> =-4A, V <sub>GS</sub> =-10V	-	3	-	nC
Gate-Drain Charge	Q <sub>gd</sub>	v <sub>GS</sub> =-10V	-	7	-	nC
Drain-Source Diode Characteristics					•	•
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =-4A	-		-1.2	V
Diode Forward Current (Note 2)	I <sub>S</sub>		-	-	-4	А
Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25°C, I <sub>F</sub> =- 4A	-	25		nS
Reverse Recovery Charge	Qrr	di/dt = -100A/ $\mu$ s <sup>(Note3)</sup>	-	31		nC

#### Notes:

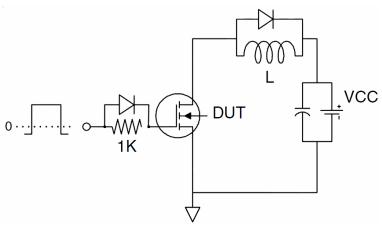
- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- **2.** Surface Mounted on FR4 Board,  $t \le 10$  sec.
- **3.** Pulse Test: Pulse Width  $\leq$  300µs, Duty Cycle  $\leq$  2%.
- 4. Guaranteed by design, not subject to production



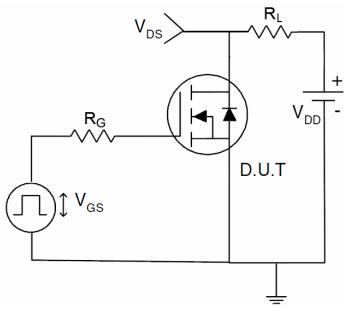
## Test Circuit 1) E<sub>AS</sub> test Circuit



## 2) Gate charge test Circuit

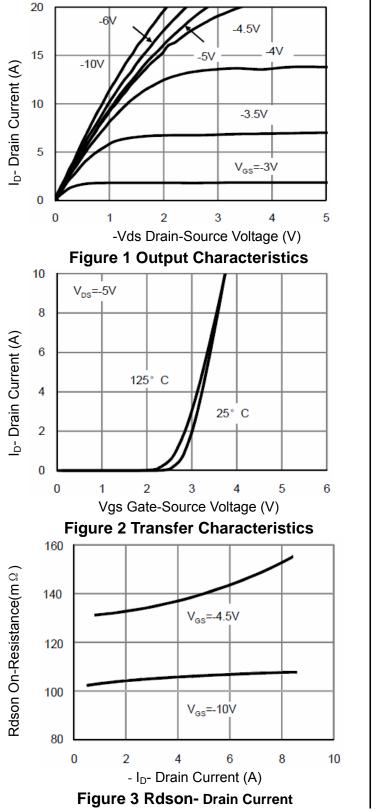


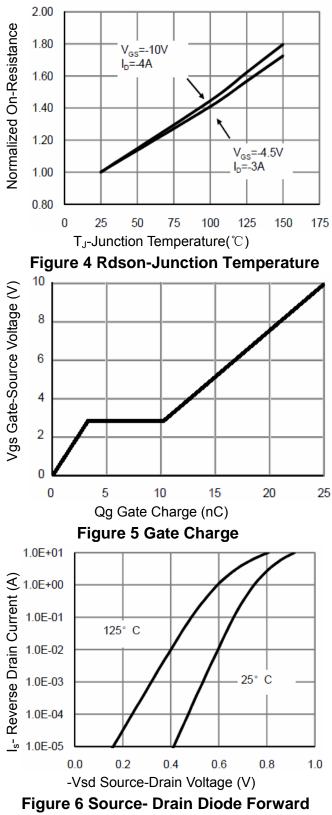
3) Switch Time Test Circuit



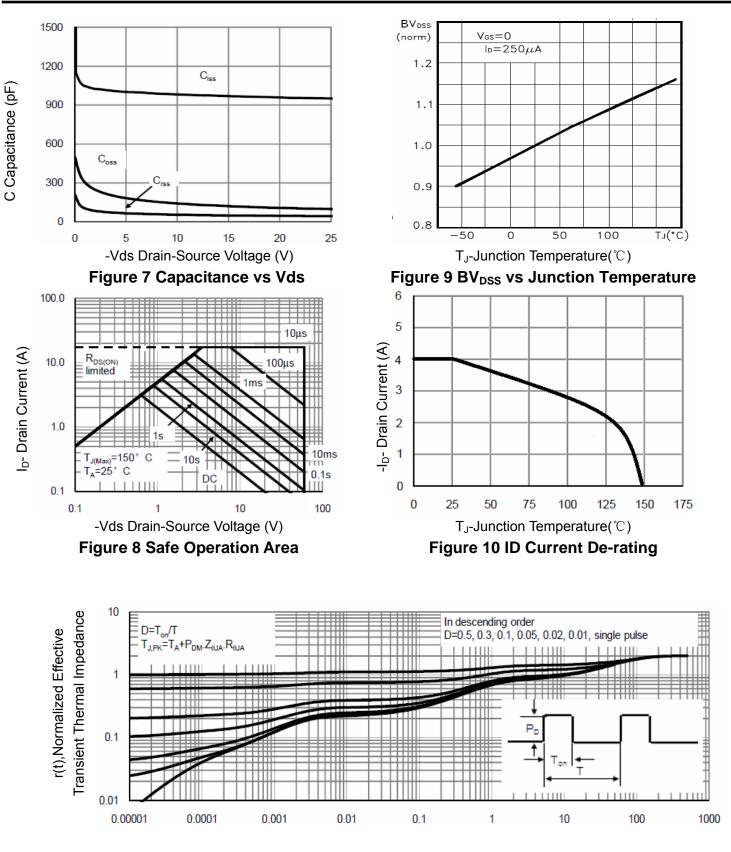


## **Typical Electrical and Thermal Characteristics (Curves)**





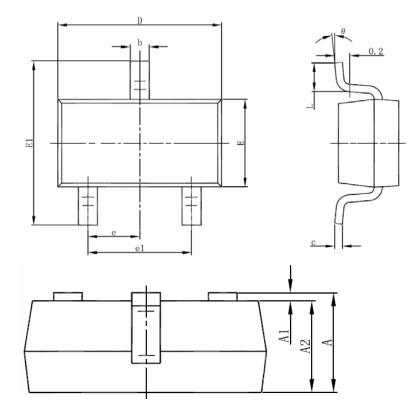




Square Wave Pluse Duration(sec) Figure 11 Normalized Maximum Transient Thermal Impedance



## SOT-23-3L Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min	Max	Min	Max	
A	1.050	1.250	0.041	0.049	
A1	0.000	0.100	0.000	0.004	
A2	1.050	1.150	0.041	0.045	
b	0.300	0.500	0.012	0.020	
с	0.100	0.200	0.004	0.008	
D	2.820	3.020	0.111	0.119	
E	1.500	1.700	0.059	0.067	
E1	2.650	2.950	0.104	0.116	
е	0.950	0.950(BSC)		(BSC)	
e1	1.800	2.000	0.071	0.079	
L	0.300	0.600	0.012	0.024	
θ	0°	8°	0°	8°	

### Notes

1. All dimensions are in millimeters.

- 2. Tolerance ±0.10mm (4 mil) unless otherwise specified
- 3. Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 5 mils.
- 4. Dimension L is measured in gauge plane.

5. Controlling dimension is millimeter, converted inch dimensions are not necessarily exact.



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